WHAT IS CLAIMED IS:

- 1. A liquid crystal display (LCD) device, comprising:
- a first substrate having a cholesteric liquid crystal (CLC) color filter;
- a second substrate having a thin film transistor;
- a seal pattern formed on one of the first and second substrates;
- a first electrode on the cholesteric liquid crystal (CLC) color filter, the first electrode being overlapped with a portion of the seal pattern;
- a second electrode on the second substrate; and
- a liquid crystal layer between the first and second electrodes.
- 2. The device according to claim 1, wherein the liquid crystal display device is a reflective liquid crystal display (LCD) device.
- 3. The device according to claim 1, wherein the liquid crystal display device is a transmissive liquid crystal display (LCD) device.
- 4. The device according to claim 1, wherein the cholesteric liquid crystal (CLC) color filter has a single-layered structure.
- 5. The device according to claim 1, wherein the cholesteric liquid crystal (CLC) color filter has a double-layered structure.
- 6. The device according to claim 1, wherein an overlapped width between the first electrode and the seal pattern is greater than zero and less than a width of the seal pattern.
- 7. The device according to claim 1, wherein the first electrode includes transparent conductive material.
- 8. The device according to claim 7, wherein the transparent conductive material is an indium tin oxide (ITO).
 - 9. The device according to claim 1, further comprising an alignment layer on the

first electrode, wherein the seal pattern partially overlaps the alignment layer.

10. A method of manufacturing a color filter substrate for a liquid crystal display (LCD) device, comprising:

forming a first alignment layer on a substrate, the substrate having a seal pattern forming area defined thereon where a seal pattern is to be formed;

forming a cholesteric liquid crystal (CLC) color filter on the first alignment layer; forming an electrode on the cholesteric liquid crystal (CLC) color filter, the electrode being overlapped with a portion of the seal pattern forming area; and forming a second alignment layer on the first electrode.

- 11. The method according to claim 10, further comprising forming an absorption layer between the substrate and the first alignment layer.
- 12. The method according to claim 10, wherein the liquid crystal display device is a reflective liquid crystal display (LCD) device.
- 13. The method according to claim 10, wherein the liquid crystal display device is a transmissive liquid crystal display (LCD) device.
- 14. The method according to claim 10, wherein the cholesteric liquid crystal (CLC) color filter has a single-layered structure.
- 15. The method according to claim 10, wherein the cholesteric liquid crystal (CLC) color filter has a double-layered structure.
- 16. The method according to claim 10, wherein an overlapped width between the electrode and the seal pattern forming area is greater than zero and less than a width of the seal pattern.
- 17. The method according to claim 10, wherein the electrode is formed of transparent conductive material.

- 18. The method according to claim 17, wherein the transparent conductive material includes an indium tin oxide (ITO).
- 19. The method according to claim 10, wherein the seal pattern forming area partially overlaps the second alignment layer.
- 20. A method of manufacturing a liquid crystal display (LCD) device, comprising: forming a first alignment layer on a first substrate; forming a cholesteric liquid crystal (CLC) color filter on the first alignment layer; forming a first electrode on the cholesteric liquid crystal (CLC) color filter; forming a second alignment layer on the first electrode; forming a seal pattern overlapping a portion of the first electrode; forming a second electrode on a second substrate; forming a third alignment layer on the second electrode; attaching the second substrate to the first substrate using the seal pattern; and providing a liquid crystal layer between the first and second substrates.
- 21. The method of claim 20, wherein the seal pattern overlaps a portion of the second alignment layer.